

10/714,998, Interference Search, US7B-70B, 11-28-05, RFA

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	213	(pattern adj density).ab.	US-PGPUB; USPAT	OR	ON	2005/11/27 13:32
L2	114644	photoresist or resist.ab.	US-PGPUB; USPAT	OR	ON	2005/11/27 13:33
L3	66	1 and 2	US-PGPUB; USPAT	OR	ON	2005/11/27 14:23
L4	1	(space adj width).clm. and ((resist or photoresist) near3 holes).clm.	US-PGPUB	OR	ON	2005/11/27 14:26
L5	1	(space adj width).clm. and (crosslink\$3 near2 plugs).clm.	US-PGPUB	OR	ON	2005/11/27 14:25
L6	1	(space adj width).clm. and (pattern adj density).clm.	US-PGPUB	OR	ON	2005/11/27 14:25
L7	2	(pattern adj density).clm. and ((resist or photoresist) near3 holes).clm.	US-PGPUB	OR	ON	2005/11/27 14:28

11-28-05

10/7/4, 998, Text search, class search; ~~Inventory Name Search~~, FEA.

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L5	1	(space adj width).clm. and (crosslink\$3 near2 plugs).clm.	US-PGPUB	OR	ON	2005/11/27 14:25
L6	1	(space adj width).clm. and (pattern adj density).clm.	US-PGPUB	OR	ON	2005/11/27 14:35
L7	2	(pattern adj density).clm. and ((resist or photoresist) near3 holes).clm.	US-PGPUB	OR	ON	2005/11/27 14:28
L8	4990	crosslink\$3 near5 (plug or via or hole)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:38
L9	2394	((resist or photoresist) near3 holes)	US-PGPUB	OR	ON	2005/11/27 14:35
L10	2394	(resist or photoresist) near3 holes	US-PGPUB	OR	ON	2005/11/27 14:37
L11	2394	9 and 10	US-PGPUB	OR	ON	2005/11/27 14:37
L12	14490	(space adj width) or (pattern adj density) or (microelectronic)	US-PGPUB	OR	ON	2005/11/27 14:48
L13	10518	(resist or photoresist) near3 holes	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:48
L14	37	8 and 13	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:39
L15	8	12 and 14	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:41

Text	L16	43	reduc\$3 adj space adj width	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:41
	L17	166352	resist adj composition or photoresist	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:42
	L18	7	16 and 17	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:44
class	L19	6589	ito.in. and takeshi.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:44
	L20	21	17 and 19	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:47
	L21	4299	430/312.ccls. or 430/252.ccls. or 430/325.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/27 14:48
	L22	3270	430/312.ccls. or 430/252.ccls. or 430/325.ccls.	US-PGPUB; USPAT	OR	ON	2005/11/27 14:48
	L23	52186	(space adj width) or (pattern adj density) or (microelectronic)	US-PGPUB; USPAT	OR	ON	2005/11/27 14:48
	L24	6948	(resist or photoresist) near3 holes	US-PGPUB; USPAT	OR	ON	2005/11/27 14:49
	L25	41	22 and 23 and 24	US-PGPUB; USPAT	OR	ON	2005/11/27 14:49

16/714,998, Inventor name search, 11/27/05, RSA.

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2	HO.IN. AND BANG-CHIEN.IN.	US-PGPUB; USPAT	OR	ON	2005/11/27 15:13